Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/779,400	IWAMURA, RYUICHI	
Examiner	Art Unit	
Raymond Phan	2111	

	SEAR	CHED				
Class	Subclass	Date	Examiner			
710	305-315, 58-64, 8-19	9/14/2006	RP			
709	201-203	9/14/2006	RP			
			:			
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INTERFERENCE SEARCHED				
Subclass	Date .	Examiner		
305,307	9/19/2006	RP		
61,310	9/19/2006	RP		
	*			
	Subclass 305,307	Subclass Date		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		